

SLOVENSKI STANDARD SIST EN 61290-10-2:2008 01-april-2008

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Optical amplifiers - Test methods - Part 10-2: Multichannel parameters - Pulse method using a gated optical spectrum analyzer (IEC 61290-10-2:2007)

Prüfverfahren für Lichtwellenleiter-Verstärker - Teil 10-2: Mehrkanalparameter -Pulsmethode bei Verwendung eines ausblendbaren optischen Spektralanalysators (IEC 61290-10-2:2007)

SIST EN 61290-10-2:2008

Amplificateurs optiques - Methodes d'essai - Partie 10-2. Parametres à canaux multiples - Méthode d'impulsion utilisant un analyseur de spectre optique stroboscopique (CEI 61290-10-2:2007)

Ta slovenski standard je istoveten z: EN 61290-10-2:2008

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SIST EN 61290-10-2:2008

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EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

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Supersedes EN 61290-10-2:2003

English version

Optical amplifiers -Test methods -Part 10-2: Multichannel parameters -Pulse method using a gated optical spectrum analyzer (IEC 61290-10-2:2007)

Amplificateurs optiques -Méthodes d'essai -Partie 10-2: Paramètres à canaux multiples -Méthode d'impulsion utilisant un analyseur de spectre optique stroboscopique (CEI 61290-10-2:2007) **Standards.iteh.ai**

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CENELEC

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

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Foreword

The text of document 86C/772/FDIS, future edition 2 of IEC 61290-10-2, prepared by SC 86C, Fibre optic systems and active devices, of IEC TC 86, Fibre optics, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61290-10-2 on 2007-10-01.

This European Standard supersedes EN 61290-10-2:2003.

EN 61290-10-2:2008 is a technical revision with updated references and cautions on proper use of the procedure.

This standard is to be used in conjunction with EN 61291-1.

The following dates were fixed:

-	latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement	(dop)	2008-08-01
-	latest date by which the national standards conflicting with the EN have to be withdrawn	(dow)	2010-10-01

The International Electrotechnical Commission (IEC) and CENELEC draw attention to the fact that it is claimed that compliance with this document may involve the use of two patents.

One patent concerns a technique for determining the amplified spontaneous emission noise of an optical amplifier in the presence of an optical signal given in Clause 4 and Clause 6.

The IEC and CENELEC take no position concerning the evidence, validity and scope of this patent right.

The holder of this patent right has as<u>sured the IEC that he</u>/she is willing to negotiate licences under reasonable and non-discriminatory terms and conditions with applicants throughout the world. In this respect, the statement of the holder of this patent, right is registered with the IEC. Information may be obtained from:

Agilent Technologies Palo Alto (CA) USA

Another patent concerns a measurement system and noise measurement apparatus for an optical amplifier given in Clause 4 and Clause 6.

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Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights other than those identified above. The IEC and CENELEC shall not be held responsible for identifying any or all such patent rights.

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 61290-10-2:2007 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 61290-3-1 NOTE Harmonized as EN 61290-3-1:2003 (not modified).

IEC 61290-10-1 NOTE Harmonized as EN 61290-10-1:2003 (not modified).

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Annex ZA

(normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

Publication	Year	<u>Title</u>	<u>EN/HD</u>	Year
IEC 61291-1	- ¹⁾	Optical amplifiers -	EN 61291-1	2006 ²⁾
		Part 1: Generic specification		

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¹⁾ Undated reference.

²⁾ Valid edition at date of issue.





Edition 2.0 2007-09

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Optical amplifiers **—Test methods DARD PREVIEW** Part 10-2: Multichannel parameters — Pulse method using a gated optical spectrum analyzer

SIST EN 61290-10-2:2008

Amplificateurs optiques Addition Methodes d'essaire 747921-2882-4546-a30f-Partie 10-2: Paramètres à canaux multiples Methode d'impulsion utilisant un analyseur de spectre optique stroboscopique

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

OPTICAL AMPLIFIERS – TEST METHODS –

Part 10-2: Multichannel parameters -Pulse method using a gated optical spectrum analyzer

FOREWORD

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- Tokyo
- Japan

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International Standard IEC 61290-10-2 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

This second edition cancels and replaces the first edition published in 2003. It is a technical revision with updated references and cautions on proper use of the procedure.

This standard is to be read in conjunction with IEC 61291-1.

The text of this standard is based on the following documents:

FDIS	Report on voting
86C/772/FDIS	86C/787/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 61290 series, published under the general title Optical amplifiers – *Test methods:*¹⁾ can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication At this date, the publication will be

- https://standards.iteh.ai/catalog/standards/sist/69747921-2882-4546-a30f-
- reconfirmed, 3e1f94e0e671/sist-en-61290-10-2-2008
- withdrawn,
- replaced by a revised edition, or
- amended.

¹⁾ The first editions of some of these parts were published under the general title *Optical fibre amplifiers – Basic specification* or *Optical amplifier test methods*.

INTRODUCTION

As far as can be determined, this part of IEC 61290 is the first International Standard on this subject. The technology of optical amplifiers is still evolving, hence amendments and new editions to this document should be expected.

Each abbreviation introduced in this standard is explained in the text at least the first time it appears. However, for an easier understanding of the whole text, a list of all abbreviations used is given in Clause 3.

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